


Search Notes 	Application/Control No. 10598934	Applicant(s)/Patent Under Reexamination NAKAHATA ET AL.
	Examiner SELIM AHMED	Art Unit 2826

SEARCHED			
Class	Subclass	Date	Examiner
257	13, 103	12/13/08	/sa/
438	46, 483, 481	12/13/08	/sa/
	Updated search	5/28/2009	/sa/

SEARCH NOTES			
Search Notes		Date	Examiner
Text search such as, Group III, III-V, nitride, GaN, GaInN, GaAlN, InGaN, AlGaIn, separate/sever/cleave/lasing/etching, substrate, crystal, nuclei/nucleus, seed, orientation, face, orientation, angle, degree, and their boolean combinations were searched.		12/13/08	/sa/
Updated search		5/28/2009	/sa/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--